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			Application Number	10/687,519	 -	
	INFORMATION DIS	CLOSURE :	Filing Date	10/16/2003		
			First Named Inventor	Truskell et al.		
	STATEMENT BY A		Art Unit	1775		
	(Use as many sheets as ne	ecessary)	Examiner Name	Turner, Archene A.		
_	Sheet 1 of 2	_	Attorney Docket Number	P75-17-03		

			U. S. PATEN	DOCUMENTS	
Examiner Initiats*	Căte No.1	Document Number Number-Kind Code ^{2 grisoury}	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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Translation is attached.

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Under the Paperwork Reduction Act of 1995, no persons are required to respond to a collection of information unless it contains a valid OMB control number, Complete if Known Substitute for form 1448/PTO **Application Number** 10/687,519 INFORMATION DISCLOSURE **Filing Date** 10/16/2003 STATEMENT BY APPLICANT First Named Inventor Truskett et al. **Art Unit** 1775 (Use as many sheets as necessary) Examiner Name Tumer, Archene A. Sheet Attorney Docket Number P75-17-03

	2	NON PATENT LITERATURE DOCUMENTS	
Examiner/ Initials*	Cite No.1	include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of	Ţ²
	G3	Tanlguchi et al., "Diamond Nanoimprint Lithography," Nanotechnology, 2002, vol. 13, no. 5, pp. 592-596(5), 2002.	
	∕G4	Kiyohara et al., "Abstract of Plasma Etching of CVD Diamond Films using an ECR-type Oxygen Source," http://www.iop.org/EJ/abstract/0957-4484/10/4/304, 9/26/2003.	
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Examiner Signature		Date Considered Considered	

if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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Substitute for form 1449A/PTO Complete if Known APPLICATION NUMBER 10/687,519 INFORMATION DISCLOSURE FILING DATE 10/16/2003 STATEMENT BY APPLICANT FIRST NAMED INVENTOR Truskett et al. Group Art Unit 1775 (use as many sheets as necessary) Examiner Name Turner, Archene A. P75-17-03 Attorney Docket Number

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Sheet	2	of	7	Attorney Docket Number	P75-17-03

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Sheet	3	of	7	Attorney Docket Number	P75-17-03			

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Standard S1.3). For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. Skind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. Applicant is to place a check mark here if English language Translation is attached. This collection of information is required by 37 CFR 1.97 and 1.98. The information is required to obtain or retain a benefit by the public which is to file (and by the USPTO to process) an application. Confidentiality is governed by 35 U.S.C. 122 and 37 CFR 1.14. This collection is estimated to take 2 hours to complete, including gathering, preparing, and submitting the completed application form to the USPTO. Time will vary depending on the individual case. Any comments on the amount of time you require to complete this form and/or suggestions for reducing this burden, should be sent to the Chief Information Officer, U.S. Patent and Trademark Office, P.O. Box 1450, Alexandria, VA 22313-1450.. DO NOT SEND FEES OR COMPLETED FORMS TO THIS ADDRESS. SEND TO: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

Turner, Archene A.

P75-17-03

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APPLICATION NUMBER 10/687,519

FILING DATE 10/16/2003

FIRST NAMED INVENTOR Truskett et al.

Group Art Unit 1775

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Examiner Name

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				FORE	IGN PATENT DOCU	MENTS		
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	STATEMENT BY APPLICANT		FIRST NAMED INVENTOR	Truskett et al.				
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Sheet	5	of	7	Attorney Docket Number	P75-17-03			

				FOREIGI	N PATENT DOCUMENTS	•	<u> </u>	
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Sheet 6 of 7			7	Examiner Name	Turner, Archene A.	
				Attorney Docket Number	P75-17-03	

OTHER PRIO	R ART -	NON PATENT LITERATURE DOCUMENTS
Examiner Initials*	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
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	E70	Mansano et al., Protective Carbon Layer for Chemical Corrosion of Stainless Steel, Diamond and Related Materials 12 (3-7); pp. 749-752, 3/1/2003
	E71	Butter et al., Production and Wetting Properties of Fluorinated Diamond-Like Carbon Coatings, Thin Solid Films, 311(1-2); pp. 107-113, 12/31/1997
Examiner Signature		Date Considered

^{*}Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Applicant's unique citation designation number (optional). Applicant is to place a check mark here if English language Translation is attached.

This collection of information is required by 37 CFR 1.97 and 1.98. The information is required to obtain or retain a benefit by the public which is to file (and by the USPTO to process) an application. Confidentiality is governed by 35 U.S.C. 122 and 37 CFR 1.14. This collection is estimated to take 2 hours to complete, including gathering, preparing, and submitting the completed application form to the USPTO. Time will vary depending on the individual case. Any comments on the amount of time you require to complete this form and/or suggestions for reducing this burden, should be sent to the Chief Information Officer, U.S. Patent and Trademark Office, P.O. Box 1450, Alexandria, VA 22313-1450... DO NOT SEND FEES OR COMPLETED FORMS TO THIS ADDRESS. SEND TO: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450...

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PTO/SB/08A (08-03)

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Substitute for form 1449A/PTO				Complete if Known		
INFO	RMATION	DISCLO	SURE	APPLICATION NUMBER	10/687,519	
STATEMENT BY APPLICANT			ICANT	FILING DATE	10/16/2003	
				FIRST NAMED INVENTOR	Truskett et al.	
(USE	e as many sheets	s as necessar,	y)	Group Art Unit	1775	
Sheet	7	of	7	Examiner Name	Turner, Archene A.	
		<u> </u>	_1	Attorney Docket Number	P75-17-03	

OTHER PRIO	R ART	NON PATENT LITERATURE DOCUMENTS						
Examiner Initials*	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.						
	E72	Hakovirta et al., Heat Resistance of Fluorinated Diamond-Like Carbon Films, Diamond and Related Materiasl 10(8); pp. 1486-1490, 8/1/2001						
	E73	Zhu et al., The Improvement of the Oxidation Resistance of TiAl Alloys by Fluorine Plasma- Based Ion Implantation, Surface and Coatings Technology 158; pp. 502-507, 9/1/2002						
	E74	Yao et al., Structural, Mechanical and Hydrophobic Properties of Fluorine-Doped Diamond-Like Carbon Films Synthesized by Plasma Immersion Ion Implantation and Deposition (PIII-D), Applied Surface Science 230; pp. 172-178, 4/17/2004						
	E75	Bailey et al., Step and Flash Imprint Lithography: Defect Analysis, Journal of Vacuum Science, B 19(6), pp. 2806-2810, 11/1/2001						
	E76	Bailey et al., Step and Flash Imprint Lithography: Template Surface Treatment and Defect Analysis, Journal of Vacuum Science, B 18(6), pp. 3572-3577, 11/1/2000						
	E77	Schneider et al., Stripes of Partially Fluorinated Alkyl Chains: Dipolar Langmuir Monolayers						
	/							
Examiner Signature		Date Considered						

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ELECTRONIC INFORMATION DISCLOSURE STATEMENT

Electronic Version v18
Stylesheet Version v18.0

Title of Invention

LOW SURFACE ENERGY TEMPLATES

Application Number:

10/687519

10/687519

Confirmation Number:

5222

First Named Applicant: Van Truskett Attorney Docket Number: P75-17-03

Art Unit:

1775

Examiner:

Archene Turner

Search string:

(6696157).pn.

US Patent Documents

Note: Applicant is not required to submit a paper copy of cited US Patent Documents

init	Cite.No.	Patent No.	Date	Patentee	Kind	Class	Subclass
	1	6696157	2004-02-24	David et al.			

Signature

Examiner Name	Øate
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ELECTRONIC INFORMATION DISCLOSURE STATEMENT

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Stylesheet Version v18.0

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LOW SURFACE ENERGY TEMPLATES

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Van Truskett

Attorney Docket Number:

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(6696157).pn

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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Sheet 1 of 3

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Comple	Complete if Known				
Application Number	10/687,519				
Filing Date	10/16/2003				
First Named Inventor	Truskett et al.				
Group Art Unit	1775				
Examiner Name	Turner, Archene A.				
Attorney Docket Number	P75-17-03				

				U.S. PATENT DOCUMEN	TS	
Exarfiner Initials*	Cite No.1	U.S. Patent Do	Kind Code ² (il known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Cotumns, Lines, Where Releyant Passages or Relevant Figures Appear
	C1	6,495,624	B1	Brown	12-17-2002	7
\ <i>\\\\</i>	C2	6,447,919	B1	Brown et al.	09-10-2002	7
147	C3	5,523,878		Wallace et al.	06-04-1996	(.
$\sqrt{177}$	C4	5,937,758		Maracas et al.	08-17-1999	
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^{&#}x27;Unique citation designation number. ²See attached Kinds of U.S. Patent Documents. ³Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁴Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁴Applicant is to place a check mark here if English language Translation is attached.

Substitute fo	or form 1449A/PT	o		Comple	te if Known
				Application Number	10/687,519
INFOF	RMATION	DISCI	OSURE	Filing Date	10/16/2003
STAT	EMENT B'	Y APP	LICANT	First Named Inventor	Truskett et al.
				Group Art Unit	1775
(us	(use as many sheets as necessary)			Examiner Name	Turner, Archene A.
Sheet	2	of	3	Attorney Docket Number	P75-17-03

	•		FOREIGN	PATENT DOCUMENTS			
Examiner Cife	Office ³	Foreign Patent Docum	Kind Code ⁵ (if known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁴
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¹Unique citation designation number. ²See attached Kinds of U.S. Patent Documents. ²Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁴Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁴Applicant is to place a check mark here if English language Translation is attached.

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OTHER PRIO	R ART -	NON PATENT LITERATURE DOCUMENTS
Examiner Initials	Cite, No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
	C6	Parikh et al.," An Intrinsic Relationship between Molecular Structure in Self-Assembled n-Alkysiloxane Monolayers and Deposition Temperature," Journal of Phys. Chem., pp7577-7590, 1994.
	C 7	Sagiv, J., "Organized Monolayers by Adsorption. 1. Formation and Structure of Oleophobic Mixed Monolayes and Solid Surfaces," Journal of the American Chemical Society, vol. 102, pp. 92-98, January 2, 1980.
	¢á	Srinivasan et al.," Alkyltrichlorosilane-Based Self-Assembled Monolayer Films for Stiction Reduction in Silicon Micromachines," Journal of Microelectromechanical Systems, Vol. 7, No. 2, p. 252-260, June 1, 1998.
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Examiner Signature		Date Considered

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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Sheet 1 of

Complete if Known							
Application Number	10/687,519						
Filing Date	10/16/2003						
First Named Inventor	Truskett et al.						
Group Art Unit	1775						
Examiner Name	Turner, Archene A.						
Attomey Docket Number	P75-17-03						

	6	U.S. Patent (Date of Publication of	Pages, Columns, Lines,
ivammer nitials*	Cite No.1	Number	Kind Code ² (if known)	Name of Patentee or Applicant of Cited Document	Cited Document MM-DD-YYYY	Where Retevant Passages or Relevant Figures Appear
	D1	3,527,062		Bilinski et al.	09-08-1970	
W//	D2	3,783,520		King	01-08-1974	
14/2	D3	3,807,027		Heisler	04-30-1974	/ ·
	D4	3,807,029		Troeger	04-30-1974	
<u> </u>	D5	3,811,665		Seelig	05-21-1974	
	D6	4,062,600		Wyse	12-13-1977	
	D7	4,070,116		Frosch et al.	01-24-1978	
	D8	4,098,001		Watson	07-04-1978	
	D9	4,119,688		Hiraoka	10-10-1978	
	D10	4,119,688		Hiraoka	10-10-1978	
	D11	4,155,169		Drake et al.	05-22-1979	
	D12	4,201,800		Alcom et al.	05-06-1980	
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	D14	4,267,212		Sakawaki	05-12-1981	
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	D16	4,337,579		De Fazio	07-06-1982	
	D17	4,355,469		Nevins et al.	10-26-1982	
	D18	4,414,750		De Fazio	11-15-1983	
	D19	4,426,247		Toshiakai et al.	01-17-1984	
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	D26	4,610,442		Oku et al.	09-09-1986	
	D27	4,657,845		Frechet et al.	04-04-1987	
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	D30	4,707,218		Giammarco et al.	11-17-1987	
	, D31	4,724,222	1	Feldman	02-09-1988	
	D32	4,737,425		LIN et al.	04-12-1988	
/	D33	4,763,88	<u> </u>	Takei	08-16-1988	
	D34	4,808,5 1	/	Holmes	02-28-1989	
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		$\overline{}$		ing is in construction with MPE	Considered	

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Substitute fo	or form 1449A/P	то		Complete if Known		
				Application Number	10/687,519	
INFOR	RMATION	DISCL	OSURE	Filing Date	10/16/2003	
STATI	EMENT B	Y APPI	LICANT	First Named Inventor	Truskett et al.	
	•			Group Art Unit	1775	
(u:	se as many shee	ets as neces	sary)	Examiner Name	Turner, Archene A.	
Sheet	2	of	16	Attorney Docket Number	P75-17-03	

	0"-	U.S. Patent Docume			Date of Publication of	Pages, Columns, Lines,
miper	Cite No. ¹		ind Code ^z iii known)	Name of Patentee or Applicant of Cited Document	Cited Document MM-DD-YYYY	Where Relevant Passages or Relevant Figures Appear
///	D35	4,826,943		ito et al.	05-02-1989	7
	D36	4,846,931		Gmitter et al.	07-11-1989	
$I \cap I$	D37	4,848,911		Uchida et al.	07-18-1989	
	D38	4,857,477		Kanamori	08-15-1989	
	D39	4,883,561		Gmitter et al.	11-28-1989	
	D40	4,891,303		Garza et al.	01-02-1990	
	D41	4,908,298		Hefferon et al.	· 03-13-1990	
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	D47 4,976,818		Hashimoto et al.	12-11-1990		
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	D50	5,053,318		Gulla et al.	10-01-1991	
	D51	5,063,321		Carter	11-05-1991	
	D52	5,071,694		Uekita et al.	12-10-1991	
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	D56	5,108,875		Thackeray et al.	04-28-1992	
	D57	5,110,514		Soane	05-05-1992	
	D58	5,126,006		Cronin et al.	06-30-1992	
	D59	5,148,036		Matsugu et al.	09-15-1992	
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<u> </u>	D68	5,234,793		Sebald et al.	08-10-1993	

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INFOR	MATION I	DISCL	.OSURE	Filing Date	10/16/2003	
STATE	EMENT BY	APP	LICANT	First Named Inventor	Truskett et al.	
:				Group Art Unit	1775	
(us	e as many sheets	s as nece	ssary)	Examiner Name	Turner, Archene A.	
Sheet	3	of	16	Attorney Docket Number	P75-17-03	

				U.S. PATENT DOCUMENT	S	
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	D69	5,240,550		Boehnke et al.	08-31-1993	- 7
	D70	5,240,878	T	Fizsimmons et al.	08-31-1993	/
17/	D71	5,242,711		DeNatale et al.	09-07-1993	
V 7	D72	5,244,818		Jokerst et al.	09-14-1993	1
<u> </u>	D73	5,270,984	Α	Mine	12-14-1993	
	D74	5,277,749		Griffith et al.	01-11-1994	
	D75	5,314,772		Kozicki et al.	05-24-1994	
	D76	5,318,870		Hartney	06-07-1994	
	D77	5,324,683		Fitch et al.	06-28-1994	\
	D78	5,328,810	1	Lowrey et al.	07-12-1994	
	D79	5,330,881		Sidman et al.	07-19-1994	
	D80	5,348,616		Hartman et al.	09-20-1994	
1	D81	5,362,606		Hartney et al.	11-08-1994	
	D82	5,366,851		Novembre	11-22-1994	
	D83	5,374,454		Bickford et al.	12-20-1994	
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	D85 .	5,380,474		Rye et al.	01-10-1995	
	D86	5,392,123		Marcus et al.	02-21-1995	1.
	D87	5,417,802		Obeng	05-23-1995	
	D88	5,421,981		Leader et al.	06-06-1995	
	D89	5,422,295		Choi et al.	06-06-1995	
	D90	5,424,549		Feldman	06-13-1995	
	D91	5,425,964		Southwell et al.	06-20-1995	
	D92	5,431,777		Austin et al.	07-11-1995	·
	D93	5,439,766	1	Day et al.	08-08-1995	
	D94	5,452,090		Progler et al.	09-19-1995	
	D95	5,453,157	1	Jeng	09-26-1995	
	D96	5,458,520	1	DeMercurio et al.	10-17-1995	
	D97	5,468,542		Crouch	11-21-1995	
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Λ	/ D99	5,527,662		Hashimoto et al.	06-18-1996	
Γ	D100	5,545,367		Bae et al.	08-13-1996	
ΠV	D101	5,566,584		Briganti	10-22-1996	0
TY	D102	5,633,505		Chung et al.	05-27-1997	
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^{&#}x27;Unique citation designation number. ²See attached Kinds of U.S. Patent Documents. ³Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁵Applicant is to place a check mark here if English language Translation is attached.

Substitute fo	r form 1449A/P	то		Complete if Known		
				Application Number	10/687,519	
INFOR	MATION	DISCL	OSURE	Filing Date	10/16/2003	
STATE	EMENT B	Y. APP	LICANT	First Named Inventor	Truskett et al.	
				Group Art Unit	1775	
(us	se as many she	ets as neces	sary)	Examiner Name	Turner, Archene A.	
Sheet	4	of	16	Attorney Docket Number	P75-17-03	

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iner	Cite No. ¹	Number	Kind Code ² (# known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Where Relevant Passages or Relevant Figures Appear
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INFOR	MATION E	DISC	LOSURE	Filing Date	10/16/2003	
STATE	EMENT BY	APF	PLICANT	First Named Inventor	Truskett et al.	
				Group Art Unit	1775	
(us	e as many sheets	as nec	essary)	Examiner Name	Turner, Archene A.	
Sheet	5	of	16	Attorney Docket Number	P75-17-03	

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Substitute f	or form 1449A/P	то		Complete if Known		
				Application Number	10/687,519	
INFO	RMATION	DISCL	OSURE	Filing Date	10/16/2003	
STAT	EMENT B	Y APP	LICANT	First Named Inventor	Truskett et al.	
				Group Art Unit	1775	
(u	se as many she	ets as neces	ssary)	Examiner Name	Turner, Archene A.	
Sheet	6	of	16	Attorney Docket Number	P75-17-03	

		U.S. Patent Do		Γ	Date of Publication of	Pages, Columns, Lines,
Examiner Initials	Cite No.1	Number	Kind Code ² (if known)	Name of Patentee or Applicant of Cited Document	Cited Document MM-DD-YYYY	Where Relevant Passages or Relevant Figures Appear
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				Application Number	10/687,519	
INFO	RMATION	DISC	LOSURE	Filing Date	10/16/2003	
STAT	LEMENT B	Y AP	PLICANT	First Named Inventor	Truskett et al.	
				Group Art Unit	1775	
(use as many sheet	ts as nec	essary)	Examiner Name	Turner, Archene A.	
Sheet	7	of	16	Attorney Docket Number	P75-17-03	

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INFOR	RMATION	DISCL	OSURE	Filing Date	10/16/2003	
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				Group Art Unit	1775	
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Sheet	8	of	16	Attorney Docket Number	P75-17-03	

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Examiner Initials*	Cite No.	Office ³	Foreign Patent Docume	nt Kind Code ^s (if known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	7
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INFO	RMATIO	N DIS	CLOSURE	Filing Date	10/16/2003
STAT	EMENT	BY A	PPLICANT	First Named Inventor	Truskett et al.
				Group Art Unit	1775
(use as many sheets as necessary)				Examiner Name	Turner, Archene A.
Sheet	9	of	16	Attorney Docket Number	P75-17-03

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Examiner Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²	
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Substitute	for form 1449B	3/PTO		Complete if Known		
		•		Application Number	10/687,519	
INFO	RMATIO	N DISC	LOSURE	Filing Date	10/16/2003	
STAT	EMENT	BY APF	PLICANT	First Named Inventor	Truskett et al.	
				Group Art Unit	1775	
(1	use as many sh	eets as nece	essary)	Examiner Name	Tumer, Archene A.	
Sheet	10	of	16	Attorney Docket Number	P75-17-03	

OTHER PRIC	R ART -	NON PATENT LITERATURE DOCUMENTS	
Examiner Initials*	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	Ľ,
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\mathcal{M}	D251	CHOI et al., "Method and System of Automatic Fluid Dispensing for Imprint Lithography Processes." U.S. Patent Application Publication 2002/0094496. Published on July 18, 2002.	
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				Application Number	10/687,519	
INFO	RMATIO	N DISC	LOSURE	Filing Date	10/16/2003	
STAT	EMENT	BY API	PLICANT	First Named Inventor	Truskett et al.	
	•			Group Art Unit	1775	
(use as many sh	eets as nec	essary)	Examiner Name	Turner, Archene A.	
Sheet	11	of	16	Attorney Docket Number	P75-17-03	

OTHER PRIO	OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS									
Examiner Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T²							
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V/	D262	HIRAI et al., "Mold Surface Treatment for Imprint Lithography.", Journal of Photopolymer Science and Technology, August 1, 2001, Vol. 14, No. 3, pp. 457-462.								
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	D269	International Search Report for PCT/US 01/26049, February 19, 2002								
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	D271	KANETOMO et al., "Robot for Use in Ultrahigh Vacuum.", Solid State Technology, August 1, 1997, pp. 63-								
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				Application Number	10/687,519	
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STA	TEMENT I	BY AP	PLICANT	First Named Inventor	Truskett et al.	
				Group Art Unit	1775	
	(use as many sh	eets as ne	cessary)	Examiner Name	Turner, Archene A.	
Sheet	12	of	16	Attorney Docket Number	P75-17-03	

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Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²	
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D276	LUCAS AEROSPACE, Free-Flex ® Pivot Catalog, January 1, 1999		
D277	MANSKY et al., "Large-Area Domain Alignment in Block Copolymer Thin Films Using Electric Fields.", Macromolecules, June 9, 1998, Vol. 31, No. 13, pp. 4399-4401.		
D278	MCMACKIN et al., "A Method of Creating a Turbulent Flow of Fluid between a Mold and a Substrate," U.S. Patent Application 10/898,034, Filed with USPTO July 23, 2004.	W	TPUBL
D279	MCMACKIN et al., "A System of Creating a Turbulent Flow of Fluid between a Mold and a Substrate," U.S. Patent Application 10/898,037, Filed with USPTO July 23, 2004.	LET.	PUBLIC
D280	MCMACKIN et al., Single Phase Fluid Imprint Lithography Method," U.S. Patent Application 10/677,639, Filed with USPTO Oct. 16, 2003.	01	& NBLK
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	D272 D273 D274 /D275 D276 D277 D278 D279 D280 D281	D272 KIM et al., "High-precision Magnetic Levitation Stage for Photolithography.", Precision Engineering, April 1, 1998, Vol 22., No. 2, pp. 66 – 77. D273 KOSEKI, "Design and Accuracy Evaluation of High-Speed and High Precision Parallel Mechanism.", Proc. Of IEEE, January 1, 1998, Intl., Conf. on Robotics & Automation, pp. 1340-1345. D274 LEE et al., "An Ultraprecision Stage for Alignment of Wafers in Advanced Microlithography.", Precision Engineering, September 1, 1997, pp. 113-122. LEE et al., "Ultra Precision Positioning System for Servo Motor-piezo Actuator Using the Dual Servo Loop and Digital filter Implementation.", American Society for Precision Engineering, January 1, 1998, pp. 287-290. D276 LUCAS AEROSPACE, Free-Flex ® Pivot Catalog, January 1, 1999 D277 MANSKY et al., "Large-Area Domain Alignment in Block Copolymer Thin Films Using Electric Fields.", Macromolecules, June 9, 1998, Vol. 31, No. 13, pp. 4399-4401. D278 MCMACKIN et al., "A Method of Creating a Turbulent Flow of Fluid between a Mold and a Substrate," U.S. Patent Application 10/898,037-Filed with USPTO July 23, 2004. D280 MCMACKIN et al., "A System of Creating a Turbulent Flow of Fluid between a Mold and a Substrate," U.S. Patent Application 10/898,037-Filed with USPTO July 23, 2004. D280 MCMACKIN et al., "System of Creating a Turbulent Flow of Fluid between a Mold and a Substrate," U.S. Patent Application 10/898,037-Filed with USPTO July 23, 2004. D280 MCMACKIN et al., "Single Phase Fluid Imprint Lithography Method," U.S. Patent Application 10/677,639, With Catalogy and Proceedings an	D272 KIM et al., "High-precision Magnetic Levitation Stage for Photolithography.", Precision Engineering, April 1, 1998, Vol 22, No. 2, pp. 66 – 77. D273 KOSEKI, "Design and Accuracy Evaluation of High-Speed and High Precision Parallel Mechanism.", Proc. of IEEE, January 1, 1998, Intl. Conf. on Robotics & Automation, pp. 1340-1345. D274 LEE et al., "An Ultraprecision Stage for Alignment of Wafers in Advanced Microlithography.", Precision Engineering, September 1, 1997, pp. 113-122. D275 LEE et al., "Ultra Precision Positioning System for Servo Motor-piezo Actuator Using the Dual Servo Loop and Digital filter Implementation.", American Society for Precision Engineering, January 1, 1998, pp. 287-290. D276 LUCAS AEROSPACE, Free-Flex © Pivot Catalog, January 1, 1999 D277 MANSKY et al., "Large-Area Domain Alignment in Block Copolymer Thin Films Using Electric Fields.", Macromolecules, June 9, 1998, Vol. 31, No. 13, pp. 4399-4401. D278 MCMACKIN et al., "A Method of Creating a Turbulent Flow of Fluid between a Mold and a Substrate," U.S. Patent Application 10/898/034, Filed with USPTO July 23, 2004. D279 MCMACKIN et al., "A System of Creating a Turbulent Flow of Fluid between a Mold and a Substrate," U.S. Patent Application 10/898,034, Filed with USPTO July 23, 2004. D280 MCMACKIN et al., "A System of Creating a Turbulent Flow of Fluid between a Mold and a Substrate," U.S. Patent Application 10/898,034, Filed with USPTO July 23, 2004. D280 MCMACKIN et al., Single Phase Fluid Imprint Lithography Method, "U.S. Patent Application 10/677,639, NOTFiled with USPTO Oct. 16, 2003. D281 MERLET, "Parallel Manipulators: State of the Art and Perspectives.", Advanced Robotics, January 1, 1994, Vol. 8, pp. 589-596.

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Substitute	for form 1449B/	/PTO		Complete if Known		
			•	Application Number	10/687,519	
INFO	RMATION	I DISC	LOSURE	Filing Date	10/16/2003	
STAT	EMENT E	BY APF	PLICANT	First Named Inventor	Truskett et al.	
				Group Art Unit	1775	
(use as many sh	eets as nece	essary)	Examiner Name	Turner, Archene A.	
Sheet	13	of	16	Attorney Docket Number	P75-17-03	

OTHER PRIO	R ART - I	NON PATENT LITERATURE DOCUMENTS	
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				Application Number	10/687,519		
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STA	ATEMENT	BY APF	LICANT	First Named Inventor	Truskett et al.		
l		·		Group Art Unit	1775		
	(use as many sh	neets as nece	ssary)	Examiner Name	Turner, Archene A.		
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$\backslash V$	D294	RAIBERT et al., "Hybrid Position/Force Control of Manipulators.", Journal of Dynamic Systems, Measurement, and Control, June 1, 1981, Vol. 102, pp. 126 – 133.		
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INFO	RMATIO	N DISC	LOSURE	Filing Date	10/16/2003
STATEMENT BY APPLICANT				First Named Inventor	Truskett et al.
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INF	ORMATION	DISC	LOSURE	Filing Date	10/16/2003	
STA	TEMENT E	BY AP	PLICANT	First Named Inventor	Truskett et al.	
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	D316	US Application No. 10/788,700, Filed 02-27-2004, SREENIVASAN et al. Full-Wafer or Large Area Imprinting with Multiple Separated Sub-Fields for High Throughput Lithography."
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10.00				Application Number	10/687,519	
INFO	RMATIO	N DISCI	LOSURE	Filing Date	October 16, 2003	
STAT	EMENT	BY APP	PLICANT	First Named Inventor	Truskett et al.	
				Group Art Unit	1762	
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Sheet	1	of	1	Attorney Docket Number	P75-17-03	

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Examiner Cite Initials* No.1	Cite No.1	Number	Kind Code ^z (if known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Where Relevant Passages or Relevant Figures Appear
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